FEATURE SELECTION

J. Elder

CSE 4404/5327 Introduction to Machine Learning and Pattern Recognition

- Analyzing individual features
 - Signal to noise ratio
 - Null hypothesis testing
- Analyzing feature vectors
 - Divergence
 - Chernoff Bound and Bhattacharyya Distance
 - Scatter Matrices
 - Feature Subset Selection



Which feature would you choose?

Probability & Bayesian Inference





CSE 4404/5327 Introduction to Machine Learning and Pattern Recognition

- Analyzing individual features
 - Signal to noise ratio
 - Null hypothesis testing
- Analyzing feature vectors
 - Divergence
 - Chernoff Bound and Bhattacharyya Distance
 - Scatter Matrices
 - Feature Subset Selection



Signal to Noise Ratio

- We wish to select features that have a high signal-to-noise ratio.
- Typically we measure the signal strength as the difference in the class-conditional means:

 $S = \mu_2 - \mu_1$

The noise can be characterized by the conditional standard deviation. If the class-conditional distributions can be assumed to have the same standard deviation, the signal-to-noise ratio can be expressed as:

$$SNR = \frac{\mu_2 - \mu_1}{\sigma}$$



Signal to Noise

$$SNR = \frac{\mu_2 - \mu_1}{\sigma}$$

- Why is this a meaningful number?
- □ Suppose that the class-conditional distributions are Gaussian, i.e.,

$$\mathbf{X}_{1} \sim \mathcal{N}(\mu_{1}, \sigma^{2}), \qquad \mathbf{X}_{2} \sim \mathcal{N}(\mu_{2}, \sigma^{2})$$

Recall that for the equal variance case, the maximum likelihood classifier will select the class based upon the Mahalanobis distance. In this case, this means that

$$\begin{vmatrix} \mathbf{x} - \boldsymbol{\mu}_1 \\ | \mathbf{x} - \boldsymbol{\mu}_1 \end{vmatrix} > \begin{vmatrix} \mathbf{x} - \boldsymbol{\mu}_2 \\ | \mathbf{x} - \boldsymbol{\mu}_2 \end{vmatrix} \rightarrow \boldsymbol{\omega}_2$$

□ wlog, suppose $\mu_1 < \mu_2$. Then the decision rule becomes

$$\begin{array}{l} x < x_{0} \rightarrow \omega_{1} \\ x > x_{0} \rightarrow \omega_{2} \end{array} \quad \text{where } x_{0} = \frac{1}{2} \left(\mu_{1} + \mu_{2} \right) \end{array}$$



Signal to Noise

Probability & Bayesian Inference

□ The probability of error is therefore:

 $p(\text{error}) = p(x > x_0 | \omega_1) p(\omega_1) + p(x < x_0 | \omega_2) p(\omega_2)$

Let $F(x;\mu,\sigma^2)$ represent the cumulative normal distribution, i.e., $F(x;\mu,\sigma^2) \triangleq \frac{1}{\sqrt{2\pi\sigma}} \int_{-\infty}^{x} \exp\left(-\frac{(x'-\mu)^2}{2\sigma^2}\right) dx'$

Then $p(\text{error}) = \frac{1}{2} (1 - F(x_0; \mu_1, \sigma^2) + F(x_0; \mu_2, \sigma^2))$

$$= \frac{1}{2} \left(1 - F\left(\frac{x_0 - \mu_1}{\sigma}; 0, 1\right) + F\left(\frac{x_0 - \mu_2}{\sigma}; 0, 1\right) \right)$$
$$= \frac{1}{2} \left(F\left(-\frac{x_0 - \mu_1}{\sigma}; 0, 1\right) + F\left(\frac{x_0 - \mu_2}{\sigma}; 0, 1\right) \right)$$
$$= \frac{1}{2} \left(F\left(-\frac{\mu_2 - \mu_1}{2\sigma}; 0, 1\right) + F\left(-\frac{\mu_2 - \mu_1}{2\sigma}; 0, 1\right) \right)$$

 $= F\left(-\frac{\mu_2 - \mu_1}{2\sigma}; 0, 1\right)$

Thus the probability of error depends only on the SNR, $\frac{\mu_2 - \mu_1}{\sigma}$.



CSE 4404/5327 Introduction to Machine Learning and Pattern Recognition

SNR: Unknown Parameters

- Thus when selecting features a good first-order rule is to select the features with maximal SNR (for minimal error).
- Normally, we do not know the class-conditional parameters, and must estimate them from data.
- We could compute an ML estimate. However, convention is to use unbiased estimates of the parameters:

$$SNR = \frac{\overline{x}_2 - \overline{x}_1}{s}$$

where
$$\overline{x}_i = \frac{1}{N_i} \sum_{\omega_j = i} x_j \text{ and } s^2 = \frac{\sum_{\omega_j = 1}^{\omega_j = 1} (x_j - \overline{x}_1)^2 + \sum_{\omega_j = 2} (x_j - \overline{x}_2)^2}{N_1 + N_2 - 2}$$



SE 4404/5327 Introduction to Machine Learning and Pattern Recognition

SNR: Unknown Parameters

Probability & Bayesian Inference

$$SNR = \frac{\overline{x}_2 - \overline{x}_1}{s}$$

where

9

$$\overline{x}_{i} = \frac{1}{N_{i}} \sum_{\omega_{j}=i} x_{j} \text{ and } s^{2} = \frac{\sum_{\omega_{j}=1}^{\omega_{j}=1} \left(x_{j} - \overline{x}_{1}\right)^{2} + \sum_{\omega_{j}=2} \left(x_{j} - \overline{x}_{2}\right)^{2}}{N_{1} + N_{2} - 2}.$$

- Note that due to sampling error, the estimated parameters will not be exactly correct.
- As a consequence, even if a feature is completely uninformative for the classification, the SNR estimate will still be non-zero.
- How can we filter out these uninformative features?



- Analyzing individual features
 - Signal to noise ratio
 - Null hypothesis testing
- Analyzing feature vectors
 - Divergence
 - Chernoff Bound and Bhattacharyya Distance
 - Scatter Matrices
 - Feature Subset Selection



Null Hypothesis Testing

$$SNR = \frac{\overline{X}_2 - \overline{X}_1}{s}.$$

One approach is to use a null hypothesis testing (NHT) procedure.
Suppose that the observations *x* are normally distributed.
Since the x̄_i are linear functions of *x*, these are also normally distributed:

$$\overline{x}_i \sim \mathcal{N}(\mu_i, \sigma^2 / N_i)$$
 (Lecture 1 – Topic 7.2)

Thus $\overline{x}_2 - \overline{x}_1$ is also normally distributed:

$$\overline{X}_2 - \overline{X}_1 \sim \mathcal{N}\left(\mu_2 - \mu_1, \frac{\sigma^2}{N_1} + \frac{\sigma^2}{N_2}\right)$$

Notice that the precision of this distribution increases linearly with the number of training inputs. In particular, if we knew the variance, we could form the test statistic

$$z = \frac{\overline{x}_2 - \overline{x}_1}{\sigma\left(\frac{1}{N_1} + \frac{1}{N_2}\right)} \sim \mathcal{N}(0, 1) \text{ if } \mu_1 = \mu_2.$$



SE 4404/5327 Introduction to Machine Learning and Pattern Recognition

The t-statistic

$$SNR = \frac{\overline{X}_2 - \overline{X}_1}{2}$$

 However, s is also a random variable, and so the SNR is not distributed as a Gaussian.

 Instead, under the null hypothesis (no difference in the means), the statistic

$$t = \frac{\overline{X}_2 - \overline{X}_1}{s\left(\frac{1}{N_1} + \frac{1}{N_2}\right)}$$

follows a student's *t* distribution with $N_1 + N_2 - 2$ degrees of freedom.







- Given this statistic, one can compute the probability that a value this large (in absolute value) would be produced were there no difference in the means (the null hypothesis).
- In the NHT procedure, we 'fail to reject' the null hypothesis if this probability exceeds a pre-specified value, typically .05.
- In selecting features, we can choose to reject any feature that does not meet this NHT criterion.



Generalizing to Multiple Classes

14

Probability & Bayesian Inference

- The NHT approach can be generalized to K>2 classes using analysis of variance (ANOVA) methods.
- We will not cover these here.



Example



Probability & Bayesian Inference





CSE 4404/5327 Introduction to Machine Learning and Pattern Recognition

Limitations of NHT for Feature Selection

Probability & Bayesian Inference

- A significant t-statistic indicates that there is sufficient training data to reveal a discriminative signal in a particular feature.
- However, it does not guarantee that including the feature will improve your classification rate on new data.
- The main problem is that the discriminative information in that feature may be redundant with information in other features.



16

ROC Curves

- As the criterion threshold is swept from right to left, p(HIT) increases, but p(FA) also increases.
- The resulting plot of p(HIT) vs p(FA) is called a receiver-operating characteristic (ROC).





Outline

- Analyzing individual features
 - Signal to noise ratio
 - Null hypothesis testing

Analyzing feature vectors

- Divergence
- Chernoff Bound and Bhattacharyya Distance
- Scatter Matrices
- Feature Subset Selection



Divergence

The divergence between two class-conditional distributions is a symmetrization of the Kullback-Leibler distance between the two distributions:

Divergence $d_{ij} = D_{ij} + D_{ji}$ where $D_{ij} + D_{ji}$ are the Kullback-Leibler divergences: $D_{ij} = \int_{-\infty}^{\infty} p(\mathbf{x} \mid \omega_i) \log \frac{p(\mathbf{x} \mid \omega_i)}{p(\mathbf{x} \mid \omega_j)} d\mathbf{x} \ P(\omega_i)$ $D_{ji} = \int_{-\infty}^{\infty} p(\mathbf{x} \mid \omega_j) \log \frac{p(\mathbf{x} \mid \omega_j)}{p(\mathbf{x} \mid \omega_j)} d\mathbf{x}$

The separability of M classes can then be defined as

$$\boldsymbol{d} = \sum_{i=1}^{M} \sum_{j=1}^{M} \boldsymbol{d}_{ij} \boldsymbol{\mathcal{P}}(\boldsymbol{\omega}_{i}) \boldsymbol{\mathcal{P}}(\boldsymbol{\omega}_{j})$$



Properties of the Divergence

Probability & Bayesian Inference

 If the components of the feature vectors are conditionally independent, then

$$\boldsymbol{d}_{ij}\left(\boldsymbol{x}\right) = \sum_{m=1}^{M} \boldsymbol{d}_{ij}\left(\boldsymbol{x}_{m}\right)$$

- The divergence is general in the sense that it can be non-zero even if the classconditional means are the same.
- However, for multivariate normal distributions with equal covariance matrices, the divergence reduces to the Mahalanobis distance between the means:

$$\boldsymbol{d}_{ij} = \left(\boldsymbol{\mu}_{i} - \boldsymbol{\mu}_{j}\right)^{t} \boldsymbol{\Sigma}^{-1} \left(\boldsymbol{\mu}_{i} - \boldsymbol{\mu}_{j}\right)$$

$$d = \sum_{i=1}^{m} \sum_{j=1}^{m} d_{ij} P(\omega_i) P(\omega_j)$$

where $d_{ij} = D_{ij} + D_{ji}$
and
$$D_{ij} = \int_{-\infty}^{\infty} p(\mathbf{x} \mid \omega_j) \log \frac{p(\mathbf{x} \mid \omega_j)}{p(\mathbf{x} \mid \omega_j)} d\mathbf{x}$$

$$D_{ji} = \int_{-\infty}^{\infty} p(\mathbf{x} \mid \omega_j) \log \frac{p(\mathbf{x} \mid \omega_j)}{p(\mathbf{x} \mid \omega_j)} d\mathbf{x}$$

A /

.



21

Chernoff Bound

The minimum classification error P_e attainable by a Bayes classifier for two classes is given by

$$P_{e} = \int_{-\infty}^{\infty} \min\left(P\left(\omega_{i}\right) p\left(\mathbf{x} \mid \omega_{i}\right), P\left(\omega_{j}\right) p\left(\mathbf{x} \mid \omega_{j}\right)\right) d\mathbf{x}.$$

Using the inequality

 $\min(a,b) \leq a^s b^{1-s}$ for $a,b \geq 0$ and $0 \leq s \leq 1$

yields the Chernoff bound:

$$P_{e} \leq P(\omega_{i})^{s} P(\omega_{j})^{1-s} \int_{-\infty}^{\infty} P(\mathbf{x} \mid \omega_{i})^{s} P(\mathbf{x} \mid \omega_{j})^{1-s} d\mathbf{x}$$

Since this must apply for all s between 0 and 1, one can (in theory) find the tightest bound by constrained minimization with respect to s.

Bhattacharyya Distance

- Using s = 1/2, and assuming multivariate normal distributions, a specific form of the Chernoff distance known as the Bhattacharyya distance can be derived.
- Again, if the covariances are equal, the Bhattacharyya distance is proportional to the Mahalanobis distance.



Scatter Matrices

Probability & Bayesian Inference

- The divergence and Chernoff bound are only readily computed for normal distributions.
- A more easily computed measure of class separability is based upon scatter matrices.
- \Box The within-class scatter matrix S_w is defined as:

$$S_{w} = \sum_{i=1}^{M} P_{i} \Sigma_{i}$$
,
where $P_{i} = \frac{n_{i}}{N}$ is the empirical estimate of the prior for Class ω_{i}
and Σ_{i} is the covariance matrix for Class ω_{i}

 \Box The between-class scatter matrix S_b is defined as:

$$S_{b} = \sum_{i=1}^{M} P_{i} \left(\mu_{i} - \mu_{o} \right) \left(\mu_{i} - \mu_{o} \right)^{t},$$

where μ_i is the mean for Class ω_i and μ_o is the pooled mean.

 \Box The mixture scatter matrix S_m is defined as:

$$S_m = E\left[\left(\mathbf{x} - \mu_o\right)\left(\mathbf{x} - \mu_o\right)^t\right].$$



- Measures of separability can be formed from these scatter matrices. Recalling that:
 - The trace of the covariance matrix is equal to the sum of the eigenalues and is a measure of the total variance in the data
 - The determinant of the covariance matrix can also be used as a measure of the total variability and is sometimes called the generalized variance
- We have the following measures of separability:

$$\mathcal{J}_{1} = \frac{\operatorname{trace}\left(\mathcal{S}_{m}\right)}{\operatorname{trace}\left(\mathcal{S}_{w}\right)} \qquad \qquad \mathcal{J}_{2} = \frac{\left|\mathcal{S}_{m}\right|}{\left|\mathcal{S}_{w}\right|} \qquad \qquad \mathcal{J}_{3} = \frac{\left|\mathcal{S}_{b}\right|}{\left|\mathcal{S}_{w}\right|}$$



25

SE 4404/5327 Introduction to Machine Learning and Pattern Recognition







CSE 4404/5327 Introduction to Machine Learning and Pattern Recognition

J. Elder

Selecting Feature Vectors

- The methods we have discussed provide a means for selecting a single feature.
- One can use any of these to select a subset of features based upon their individual merits.
- However, this does not take into account the statistical redundancy between these features.
- Ch 5.7.2 of the textbook discusses some heuristics for reducing this redundancy when selecting feature subsets. We will not discuss these here.
- We will discuss more powerful and principled methods for selecting feature subsets (dimensionality reduction, boosting) in coming lectures.



SE 4404/5327 Introduction to Machine Learning and Pattern Recognition